

August 1986 Revised March 2000

DM74LS194A 4-Bit Bidirectional Universal Shift Register

General Description

This bidirectional shift register is designed to incorporate virtually all of the features a system designer may want in a shift register; they feature parallel inputs, parallel outputs, right-shift and left-shift serial inputs, operating-mode-control inputs, and a direct overriding clear line. The register has four distinct modes of operation, namely:

Parallel (broadside) load

- Shift right (in the direction Q_A toward Q_D)
- Shift left (in the direction QD toward QA)

Inhibit clock (do nothing)

Synchronous parallel loading is accomplished by applying the four bits of data and taking both mode control inputs, S0 and S1, HIGH. The data is loaded into the associated flip-flops and appear at the outputs after the positive transition of the clock input. During loading, serial data flow is inhibited

Shift right is accomplished synchronously with the rising edge of the clock pulse when S0 is HIGH and S1 is LOW. Serial data for this mode is entered at the shift-right data input. When S0 is LOW and S1 is HIGH, data shifts left synchronously and new data is entered at the shift-left serial input.

Clocking of the flip-flop is inhibited when both mode control inputs are LOW.

Features

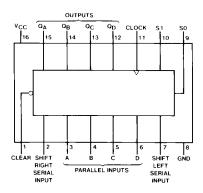
- Parallel inputs and outputs
- Four operating modes:
 - Synchronous parallel load
 - Right shift
 - Left shift Do nothing
- Positive edge-triggered clocking
- Direct overriding clear

Ordering Code:

Order Number	Package Number	Package Description				
DM74LS194AM	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow				
DM74LS194AN	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide				

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagram

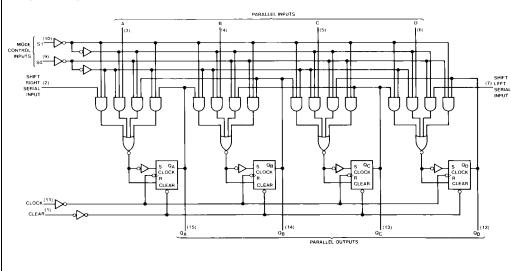


Function Table

Inputs						Outputs							
Clear	Мс	de	Clock	Se	Serial Parallel			Q _A	Q _B	Q _C	QD		
Clear	S1	S0	CIUCK	Left	Right	Α	В	С	D	Q A	∝в	~C	⊶D
L	Х	Х	Х	Х	X	Х	Х	Χ	Х	L	L	L	L
Н	Х	Χ	L	Х	Χ	Х	Х	Χ	Χ	Q_{A0}	Q_{B0}	Q_{C0}	Q_{D0}
Н	Н	Н	1	Х	Χ	а	b	С	d	а	b	С	d
Н	L	Н	1	Х	Н	Х	Х	Χ	Χ	Н	Q_An	Q_{Bn}	Q_{Cn}
Н	L	Н	1	Х	L	Х	Χ	Χ	Χ	L	Q_{An}		Q_Cn
Н	Н	L	1	Н	Χ	Х	Х	Χ	Χ	Q_{Bn}	Q_{Cn}	Q_Dn	Н
Н	Н	L	1	L	Χ	Х	Х	Χ	Χ	Q_{Bn}	Q_Cn	Q_{Dn}	L
Н	L	L	Х	Х	Χ	Х	Х	Χ	Χ	Q_{A0}	Q_{B0}	Q_{C0}	Q_{D0}

- H = HIGH Level (steady state)
 L = LOW Level (steady state)
 X = Don't Care (any input, including transitions)
 ↑ = Transition from LOW-to-HIGH level
 a, b, c, d = The level of steady state input at inputs A, B, C or D, respectively.
 Q_{A0}, Q_{B0}, Q_{C0}, Q_{D0} = The level of Q_A, Q_B, Q_C, or Q_D, respectively, before the indicated steady state input conditions were established.
 Q_{An}, Q_{Bn}, Q_{Cn}, Q_{Dn} = The level of Q_A, Q_B, Q_C, respectively, before the most-recent ↑ transition of the clock.

Logic Diagram



Absolute Maximum Ratings(Note 1)

Supply Voltage 7V
Input Voltage 7V

Operating Free Air Temperature Range $0^{\circ}\text{C to } +70^{\circ}\text{C}$ Storage Temperature Range $-65^{\circ}\text{C to } +150^{\circ}\text{C}$ Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Recommended Operating Conditions

Symbol	Param	Min	Nom	Max	Units		
V _{CC}	Supply Voltage	4.75	5	5.25	V		
V _{IH}	HIGH Level Input Voltag	2			V		
V _{IL}	LOW Level Input Voltag	е			0.8	V	
I _{ОН}	HIGH Level Output Cur	rent			-0.4	mA	
I _{OL}	LOW Level Output Curr			8	mA		
f _{CLK}	Clock Frequency (Note 2)		0		25	MHz	
	Clock Frequency (Note	0		20	IVITZ		
t _W	Pulse Width	Clock	20			20	
	(Note 4)	Clear	20			ns	
t _{SU}	Setup Time	Mode	30				
	(Note 4)	Data	20			ns	
t _H	Hold Time (Note 4)		0			ns	
t _{REL}	Clear Release Time (Note 4)		25			ns	
T _A	Free Air Operating Temperature		0		70	°C	

Note 2: $C_L = 15 \text{ pF}, T_A = 25^{\circ}\text{C} \text{ and } V_{CC} = 5\text{V}.$

Note 3: $C_L = 50$ pF, $R_L = 2$ k Ω , $T_A = 25^{\circ}C$ and $V_{CC} = 5V$.

Note 4: $T_A = 25^{\circ}C$ and $V_{CC} = 5V$.

Electrical Characteristics

over recommended operating free air temperature range (unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ (Note 5)	Max	Units
VI	Input Clamp Voltage	V _{CC} = Min, I _I = -18 mA			-1.5	V
V _{OH}	HIGH Level	V _{CC} = Min, I _{OH} = Max	2.7	3.4		V
	Output Voltage	$V_{IL} = Max, V_{IH} = Min$	2.1			V
V _{OL}	LOW Level	V _{CC} = Min, I _{OL} = Max		0.35	0.5	V
	Output Voltage	$V_{IL} = Max, V_{IH} = Min$				
		I _{OL} = 4 mA, V _{CC} = Min			0.4	
II	Input Current @ Max Input Voltage	V _{CC} = Max, V _I = 7V			0.1	mA
I _{IH}	HIGH Level Input Current	V _{CC} = Max, V _I = 2.7V			20	μΑ
I _{IL}	LOW Level Input Current	V _{CC} = Max, V _I = 0.4V			-0.4	mA
Ios	Short Circuit Output Current	V _{CC} = Max (Note 6)	-20		-100	mA
I _{CC}	Supply Current	V _{CC} = Max (Note 7)		15	23	mA

Note 5: All typicals are at $V_{CC} = 5V$, $T_A = 25^{\circ}C$.

Note 6: Not more than one output should be shorted at a time, and the duration should not exceed one second.

Note 7: With all outputs open, inputs A through D grounded, and 4.5V applied to S0, S1, CLEAR, and the serial inputs, I_{CC} is tested with momentary ground, then 4.5V applied to CLOCK.

Switching Characteristics

at $V_{CC} = 5V$ and $T_A = 25^{\circ}C$

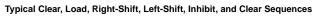
Symbol	Parameter	From (Input)	C _L = 50 pF	Units	
		To (Output)	Min	Max	Gills
f _{MAX}	Maximum Clock Frequency		20		MHz
t _{PLH}	Propagation Delay Time LOW-to-HIGH Level Output	Clock to Any Q		26	ns
t _{PHL}	Propagation Delay Time HIGH-to-LOW Level Output	Clock to Any Q		35	ns
t _{PHL}	Propagation Delay Time HIGH-to-LOW Output	Clear to Any Q		38	ns

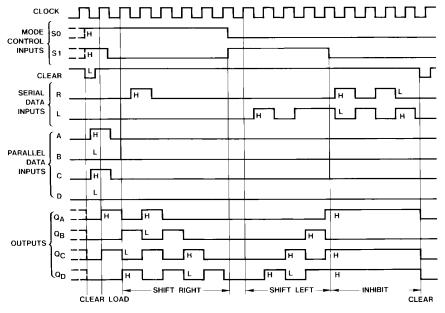
Note 8: All typicals are at $V_{CC} = 5V$, $T_A = 25$ °C.

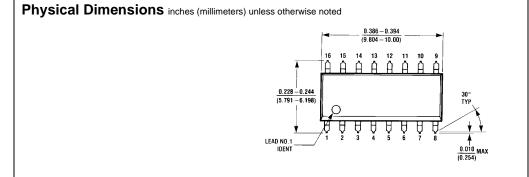
Note 9: Not more than one output should be shorted at a time, and the duration should not exceed one second.

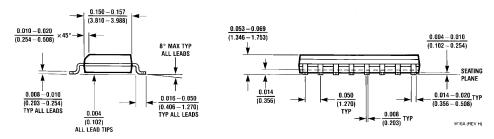
Note 10: With all outputs open, inputs A through D grounded, and 4.5V applied to S0, S1, CLEAR, and the serial inputs, I_{CC} is tested with momentary ground, then 4.5V applied to CLOCK.

Timing Diagram









16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow Package Number M16A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued) 0.740 = 0.780 (18.80 = 19.81) 0.090 (2.286)16 15 14 13 12 11 10 9 16 15 INDEX 0.250 ± 0.010 (6.350 ± 0.254) PIN NO. 1 IDENT PIN NO. 1 IDENT 1 2 3 4 5 6 7 8 1 2 _ OPTION 01 OPTION 02 $\frac{0.065}{(1.651)}$ $\frac{0.130 \pm 0.005}{(3.302 \pm 0.127)}$ $\frac{0.060}{(1.524)}$ TYP 0.300 **-** 0.320 (7.620 **-** 8.128) 4° TYP OPTIONAL 0.145 = 0.200 (3.683 = 5.080) 95°±5° 0.008 = 0.016 (0.203 = 0.406) TYP 90° ± 4° TYP $\frac{0.020}{(0.508)}$ 0.280 (7.112) MIN 0.125 - 0.150 (3.175 - 3.810) $\frac{0.030 \pm 0.015}{(0.762 \pm 0.381)}$ 0.014 - 0.023 0.100 ± 0.010 (0.325 +0.040 -0.015 (0.356 - 0.584)(2.540 ± 0.254) TYP 0.050 ± 0.010 N16E (REV F) (1.270 ± 0.254) TYP (8.255 **+**1.016)

16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N16E

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